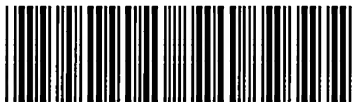


# Search Notes



Application/Control No.

10/537,677

Examiner

Rip A. Lee

Applicant(s)/Patent under Reexamination

SCHULTE ET AL.

Art Unit

1713

## SEARCHED

Class	Subclass	Date	Examiner
586	53	02-21-2007	
526	160		
526	170		
526	943		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	02-21-2007	
STN structure search	02-21-2007	